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FDC3612

100V N-Channel PowerTrench® MOSFET

General Description

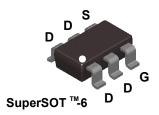
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low R_{DS(ON)} and fast switching speed.

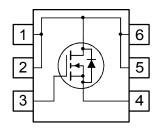
Applications

• DC/DC converter

Features

- 2.6 A, 100 V $R_{DS(ON)} = 125 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 135 \text{ m}\Omega$ @ $V_{GS} = 6 \text{ V}$
- High performance trench technology for extremely low $R_{\text{DS(ON)}}$
- Low gate charge (14nC typ)
- High power and current handling capability
- · Fast switching speed





Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|---------------------------------------|---------------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 100 | V |
| V _{GSS} | Gate-Source Voltage | | ± 20 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 2.6 | A |
| | - Pulsed | | 20 | |
| E _{AS} | Single Pulse Avalanche Energy | (Note 3) | 37 | mJ |
| P_D | Maximum Power Dissipation | (Note 1a) | 1.6 | W |
| | | (Note 1b) | 0.8 | |
| T _J , T _{STG} | Operating and Storage Junction Temper | erature Range | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 78 | °C/W |
|-----------------|---|-----------|----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 30 | °C/W |

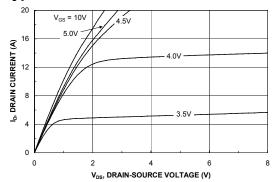
Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|---------|-----------|------------|------------|
| .362 | FDC3612 | 7" | 8mm | 3000 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|--|--|-----|-----------------|-------------------|-------|
| Drain-So | ource Avalanche Ratings (Note | 2) | | | I | l . |
| W _{DSS} | Drain-Source Avalanche Energy | Single Pulse, $V_{DD} = 50 \text{ V}$, $I_D = 2.6 \text{ A}$ | | | 90 | mJ |
| I _{AR} | Drain-Source Avalanche Current | | | | 2.6 | Α |
| Off Char | acteristics | | | | I | |
| BV _{DSS} | Drain–Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$ | 100 | | | V |
| ΔBV _{DSS} ΔT, _J | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | 99 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 80 V, V _{GS} = 0 V | | | 10 | μА |
| I _{GSSF} | Gate-Body Leakage, Forward | V _{GS} = 20 V, V _{DS} = 0 V | | | 100 | nA |
| I _{GSSR} | Gate–Body Leakage, Reverse | V _{GS} = -20 V, V _{DS} = 0 V | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | 2 | 2.3 | 4 | V |
| $\Delta V_{GS(th)}$ ΔT_J | Gate Threshold Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | | - 6 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On Resistance | $V_{GS} = 10 \text{ V}, \ I_D = 2.6 \text{ A}$ $V_{GS} = 6.0 \text{ V}, \ I_D = 2.5 \text{ A}$ $V_{GS} = 10 \text{ V}, \ I_D = 2.6 \text{ A}; T_J = 125^{\circ}\text{C}$ | | 86 91 157 | 125 135 240 | mΩ |
| I _{D(on)} | On-State Drain Current | V _{GS} = 10 V, V _{DS} = 5 V | 10 | | | Α |
| g _{FS} | Forward Transconductance | V _{DS} = 10 V, I _D = 2.6 A | | 10 | | S |
| Dynamic | Characteristics | 1 | | | 1 | I |
| C _{iss} | Input Capacitance | V _{DS} = 50 V, V _{GS} = 0 V, | | 660 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 55 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 40 | | pF |
| R_g | Gate Resistance | | 0.1 | 1.4 | 3.0 | Ω |
| | ng Characteristics (Note 2) | | • | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 50 V, I _D = 1 A, | | 6 | 11 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$ | | 3.5 | 7 | ns |
| t _{d(off)} | Turn-Off Delay Time | - | | 23 | 37 | ns |
| t _f | Turn-Off Fall Time | - | | 3.7 | 7.4 | ns |
| Q _g | Total Gate Charge | V _{DS} = 50 V, I _D = 2.6 A, | | 14 | 20 | nC |
| Q _{gs} | Gate–Source Charge | V _{GS} = 10 V | | 2.3 | | nC |
| Q _{gd} | Gate-Drain Charge | - | | 3.6 | | nC |
| | ource Diode Characteristics | and Maximum Ratings | | | ı | |
| l _s | Maximum Continuous Drain–Source | Ţ | | | 1.3 | Α |
| V _{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 1.3 \text{ A} \text{(Note 2)}$ | | 0.76 | 1.2 | V |
| t _{rr} | Diode Reverse Recovery Time | I _F = 2.6 A | | 31 | | nS |
| Q _{rr} | Diode Reverse Recovery Charge | $d_{iF}/d_t = 100 \text{ A/µs}$ (Note 2) | | 56 | | nC |

- 1. R_{BJA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $\,R_{\theta JC}^{}$ is guaranteed by design while $R_{\theta CA}^{}$ is determined by the user's board design.
- a. 78°C/W when mounted on a 1in² pad of 2oz copper on FR-4 board.
- b. 156°C/W when mounted on a minimum pad.
- 2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%
- 3. E_{AS} of 37 mJ is based on starting $T_J = 25$ °C; N-ch: L = 3 mH, $I_{AS} = 5$ A, $V_{DD} = 100$ V, $V_{GS} = 10$ V. 100% test at L = 0.3 mH, $I_{AS} = 11$ A.

Typical Characteristics



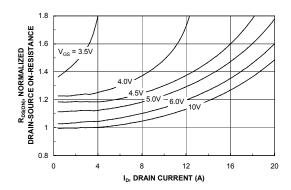
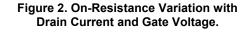
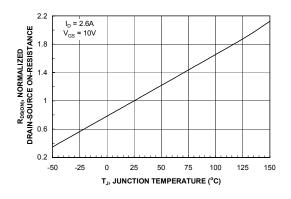


Figure 1. On-Region Characteristics.





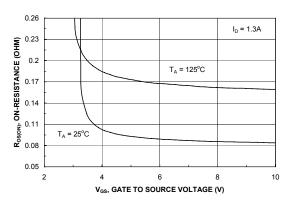
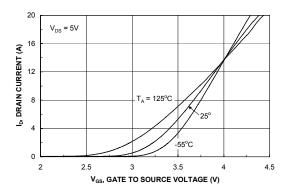


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



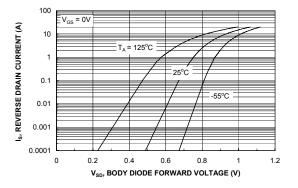
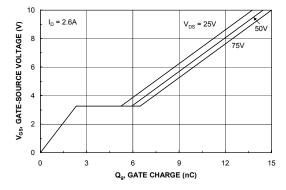


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



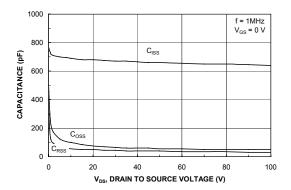
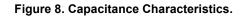
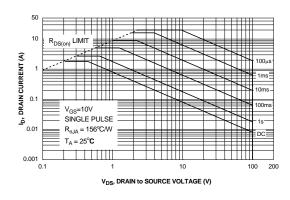


Figure 7. Gate Charge Characteristics.





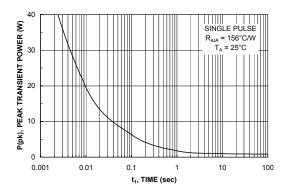


Figure 9. Maximum Safe Operating Area.



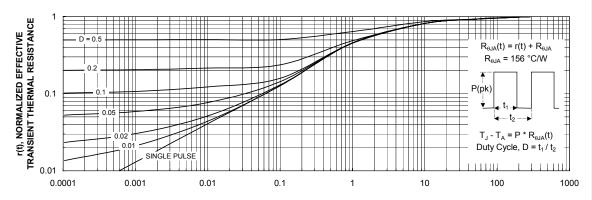


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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